

Notice of References Cited	Application/Control No. 09/891,778	Applicant(s)/Patent Under Reexamination HENNENLOTTER, WILLIAM	
	Examiner Chirag G Shah	Art Unit 2664	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,757,297	06-2004	Chin, Hon Wah	370/469
	B	US-6,823,408	11-2004	Nakamura et al.	710/100
	C	US-6,842,780	01-2005	Frei et al.	709/221
	D	US-2001/0042118	11-2001	Miyake et al.	709/223
	E	US-5,473,602	12-1995	McKenna et al.	370/256
	F	US-6,035,331	03-2000	Soga et al.	709/223
	G	US-6,308,282	10-2001	Huang et al.	714/4
	H	US-6,366,584	04-2002	Gulliford et al.	370/403
	I	US-6,456,600	09-2002	Rochberger et al.	370/255
	J	US-6,618,366	09-2003	Furukawa et al.	370/338
	K	US-6,754,207	06-2004	Hesse, John	370/388
	L	US-2002/0089964	07-2002	HANSEN et al.	370/341
	M	US-6,078,575	06-2000	Dommety et al.	370/338

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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